

20V N-Channel Enhancement Mode MOSFET

General Features

- Proprietary Advanced Planar Technology
- Rugged Polysilicon Gate Cell Structure
- > Fast Switching Speed
- ➤ RoHS Compliant
- Halogen-free Available

BV_{DSS}	R _{DS(ON)} (Typ.)	I_D		
20V	1.55Ω	500mA		

Applications

- ➤ High Efficiency SMPS
- ➤ Adaptor/Charger
- Active PFC





Ordering Information

- 1					
	Part Number	Part Number Package		Remark	
	FTZ20N01G5	SOT-23	N01	Halogen Free	

Absolute Maximum Ratings

Symbol	Parameter	FTZ20N01G5	Unit	
$V_{ m DSS}$	Drain-to-Source Voltage ^[1]	20	V	
I_D	Continuous Drain Current	0.5	٨	
I_{DM}	Pulsed Drain Current ^[2]	2	A	
P_D	Power Dissipation	0.5	W	
V_{GS}	Gate-to-Source Voltage	±20	V	
T_{L}	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300	°C	
T _J and T _{STG}	Operating and Storage Temperature Range	-55 to 150		

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	FTZ20N01G5	Unit
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient	250	K/W



Electrical Characteristics

OFF Characteristics

 $T_A = 25$ °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	20			V	V _{GS} =0V, I _D =250μA
I _{DSS}	Drain-to-Source Leakage Current		0.38		nA	V _{DS} =10V, V _{GS} =0V
I_{GSS}	Gate-to-Source Leakage Current		2		nA	V_{GS} =+20V, V_{DS} =0V
			-2			V _{GS} =-20V, V _{DS} =0V

ON Characteristics

 $T_A\!=\!\!25\,^{\circ}\!\mathrm{C}$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
$R_{DS(ON)}$	Static Drain-to-Source On-Resistance		1.55		Ω	$V_{GS}=10V$, $I_{D}=50mA^{[3]}$
$V_{\rm GS(TH)}$	Gate Threshold Voltage		4.65		V	$V_{GD}=0V$, $I_D=1\mu A$
			5.39		V	V _{GD} =0V, I _D =250μA

Source-Drain Diode Characteristics

T_A=25°C unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Units	Test Conditions
V_{SD}	Diode Forward Voltage		0.78		V	I _{SD} =50mA ^[3] , V _{GS} =0V

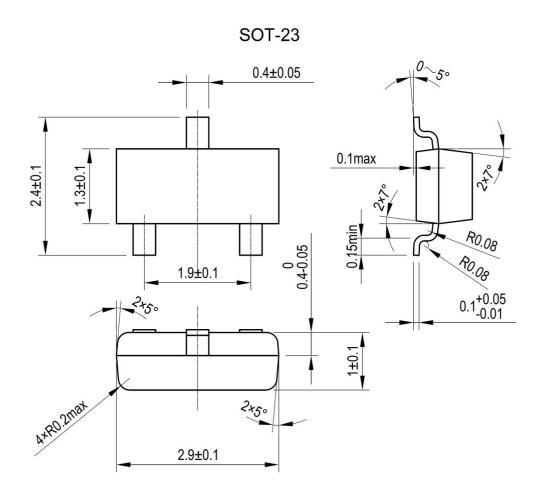
NOTE:

[1] $T_J = +25^{\circ}C$ to $+150^{\circ}C$

[2] Repetitive rating, pulse width limited by maximum junction temperature. [3] Pulse width \(\le 380\mu s; \) duty cycle \(\le 2\% \).



Package Dimensions





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